## TOSHIBA FIELD EFFECT TRANSISTOR SILICON N-CHANNEL DUAL GATE MOS TYPE

# 3 S K 2 9 2

### TV TUNER, VHF RF AMPLIFIER APPLICATION

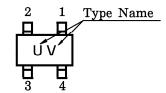
Superior Cross Modulation Performance.

Low Reverse Transfer Capacitance :  $C_{rss} = 20 fF (Typ.)$ : NF = 1.4dB (Typ.) Low Noise Figure

### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	$V_{DS}$	12.5	V
Gate 1-Source Voltage	V <sub>G1S</sub>	±8	V
Gate 2-Source Voltage	$v_{G2S}$	±8	V
Drain Current	$I_{\mathbf{D}}$	30	mA
Drain Power Dissipation	$P_{\mathbf{D}}$	150	mW
Channel Temperature	$\mathrm{T_{ch}}$	125	°C
Storage Temperature Range	$T_{ m stg}$	-55~125	°C

**MARKING** 



Unit in mm

0.85

1. 2. 3. 4.	GATE 1 GATE 2 DRAIN SOURCE	0.05±0.05
JEI	DEC	
EIA	J	_
TOS	SHIBA	2-3J1A

+ 0.25 1.50 - 0.15

2.9 ± 0.2

0.55

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

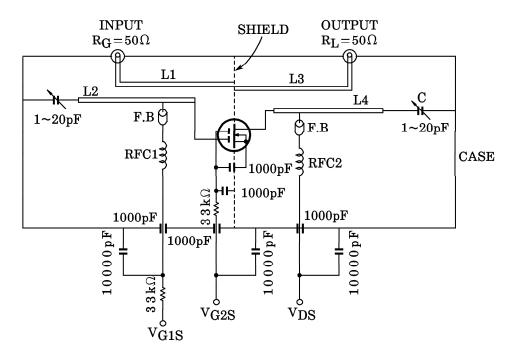
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate 1 Leakage Current	$I_{G1SS}$	$V_{DS} = 0, V_{G1S} = \pm 6V, V_{G2S} = 0$	<u> </u>	_	±50	nA
Gate 2 Leakage Current	$I_{G2SS}$	$V_{DS} = 0, V_{G1S} = 0, V_{G2S} = \pm 6V$	_		±50	nA
Drain-Source Voltage	V <sub>(BR) DSX</sub>	$egin{array}{c} V_{G1S} = -0.5V, \ V_{G2S} = -0.5V, \ I_{D} = 100 \mu A \end{array}$	12.5	_	_	v
Drain Current	$I_{ m DSS}$	$V_{DS}=6V, V_{G1S}=0, V_{G2S}=4.5V$	_	_	0.1	mA
Gate 1-Source Cut-off Voltage	V <sub>G1S (OFF)</sub>	$egin{array}{c} V_{ m DS}\!=\!6{ m V},\ V_{ m G2S}\!=\!4.5{ m V},\ I_{ m D}\!=\!100\mu{ m A} \end{array}$	0.3	0.9	1.3	V
Gate 2-Source Cut-off Voltage	V <sub>G2S</sub> (OFF)	$egin{array}{c} V_{ m DS}\!=\!6{ m V},\ V_{ m G2S}\!=\!4.0{ m V},\ I_{ m D}\!=\!100\mu{ m A} \end{array}$	0.5	1.0	1.5	V
Forward Transfer Admittance	Y <sub>fs</sub>	$egin{array}{c} V_{ m DS}\!=\!6{ m V,}\ V_{ m G2S}\!=\!4.5{ m V,}\ I_{ m D}\!=\!10{ m mA,}\ f\!=\!1{ m kHz} \end{array}$	19.5	23.5	_	mS
Input Capacitance	$\mathrm{C}_{\mathrm{iss}}$	V <sub>DS</sub> =6V, V <sub>G2S</sub> =4.5V,	_	2.5	3.1	pF
Reverse Transfer Capacitance	$\mathrm{c}_{\mathrm{rss}}$	$I_{\rm D}=10{ m mA}, \ { m f}=1{ m MHz}$	_	20	40	fF
Power Gain	G <sub>ps</sub>	V <sub>DS</sub> =6V, V <sub>G2S</sub> =4.5V,	23.5	26.0	_	dB
Noise Figure	NF	$I_D=10$ mA, $f=500$ MHz (Fig.1)	_	1.4	2.5	] ub

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The information contained herein is subject to change without notice.

Fig.1 Gps/NF TEST CIRCUIT



L1~L4 :  $\phi$ 0.8mm SILVER PLATED COPPER WIRE

C : AIR TRIMMER TTA25A200A (MURATA MFG, Co., Ltd.)

RFC 1 :  $\phi$ 0.35mm VEW 3I.D.7T RFC 2 :  $\phi$ 0.35mm VEW 3I.D.10T

